

Notice of References Cited	Application/Control No. 10/631,928	Applicant(s)/Patent Under Reexamination TEOH ET AL.	
	Examiner Victor X. Nguyen	Art Unit 3734	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,527,337	06-1996	Stack et al.	606/198
*	B	US-5,944,730	08-1999	Nobles et al.	606/151
*	C	US-5,928,260	07-1999	Chin et al.	606/200
*	D	US-6,346,117	02-2002	Greenhalgh, E. Skott	606/200
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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